

Search Notes (continued)

Application/Control No.

10/775,080

Examiner

Chun-Kuan (Mike) Lee

Applicant(s)/Patent under
Reexamination

SAKIYAMA ET AL.

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
710	2	3/8/2006	CHUN-KUAN Lee
710	13	3/8/2006	↓
710	17	3/8/2006	
710	68	3/8/2006	
710	74	3/8/2006	
710	300-301	3/8/2006	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	3/8/2006	CHUN-KUAN Lee